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Standards

Irish Standard
I.S. EN IEC 62435-8:2020

Electronic components - Long-term storage of electronic semiconductor devices - Part 8: Passive electronic devices

I.S. EN IEC 62435-8:2020

Incorporating amendments/corrigenda/National Annexes issued since publication:

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National Foreword

I.S. EN IEC 62435-8:2020 is the adopted Irish version of the European Document EN IEC 62435-8:2020, Electronic components - Long-term storage of electronic semiconductor devices - Part 8: Passive electronic devices

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EUROPEAN STANDARD

EN IEC 62435-8

NORME EUROPÉENNE

EUROPÄISCHE NORM

August 2020

ICS 31.020

English Version

**Electronic components - Long-term storage of electronic
semiconductor devices - Part 8: Passive electronic devices
(IEC 62435-8:2020)**

Composants électroniques - Stockage de longue durée des
dispositifs électroniques à semiconducteurs - Partie 8 :
Dispositifs électroniques passifs
(IEC 62435-8:2020)

Elektronische Bauteile - Langzeitlagerung elektronischer
Halbleiterbauelemente - Teil 8: Passive elektronische
Bauelemente
(IEC 62435-8:2020)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

EN IEC 62435-8:2020 (E)**European foreword**

The text of document 47/2595/CDV, future edition 1 of IEC 62435-8, prepared by IEC/TC 47 "Semiconductor devices" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62435-8:2020.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2021-05-12
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2023-08-12

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The text of the International Standard IEC 62435-8:2020 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

| | | |
|--------------------------|------|---|
| IEC 60721-3-1 | NOTE | Harmonized as EN IEC 60721-3-1 |
| IEC/TR 62258-3 | NOTE | Harmonized as CLC/TR 62258-3 |
| IEC 62435-1 | NOTE | Harmonized as EN 62435-1 |
| IEC 62435-2 | NOTE | Harmonized as EN 62435-2 |
| IEC 62435-3 | NOTE | Harmonized as EN IEC 62435-3 |
| IEC 62435-4 | NOTE | Harmonized as EN IEC 62435-4 |
| IEC 62435-5 | NOTE | Harmonized as EN 62435-5 |
| IEC 62435-6 | NOTE | Harmonized as EN IEC 62435-6 |
| IEC 62435-7 ¹ | NOTE | Harmonized as EN IEC 62435-7 ² |

¹ Under preparation. Stage at the time of publication: IEC AFDIS 62435-7:2020.

² Under preparation. Stage at the time of publication: prEN IEC 62435-7:2019.

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

| <u>Publication</u> | <u>Year</u> | <u>Title</u> | <u>EN/HD</u> | <u>Year</u> |
|--------------------|-------------|--|--------------|-------------|
| IEC 60749-20 | - | Semiconductor devices - Mechanical and climatic test methods - Part 20: Resistance of plastic encapsulated SMDs to the combined effect of moisture and soldering heat | EN 60749-20 | - |
| IEC 60749-20-1 | - | Semiconductor devices - Mechanical and climatic test methods - Part 20-1: Handling, packing, labelling and shipping of surface-mount devices sensitive to the combined effect of moisture and soldering heat | - | - |
| IEC 61760-4 | - | Surface mounting technology - Part 4: Classification, packaging, labelling and handling of moisture sensitive devices | EN 61760-4 | - |
| JEDEC J-STD-075 | - | Classification of non-IC electronic components for assembly processes | - | - |

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IEC 62435-8

Edition 1.0 2020-07

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Electronic components – Long-term storage of electronic semiconductor devices –
Part 8: Passive electronic devices**

**Composants électroniques – Stockage de longue durée des dispositifs
électroniques à semiconducteurs –
Partie 8: Dispositifs électroniques passifs**





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IEC 62435-8

Edition 1.0 2020-07

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Electronic components – Long-term storage of electronic semiconductor devices –
Part 8: Passive electronic devices**

**Composants électroniques – Stockage de longue durée des dispositifs électroniques à semiconducteurs –
Partie 8: Dispositifs électroniques passifs**

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ELECTROTECHNICAL
COMMISSION

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ELECTRONIC COMPONENTS – LONG-TERM STORAGE
OF ELECTRONIC SEMICONDUCTOR DEVICES –****Part 8: Passive electronic devices**

FOREWORD

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International Standard IEC 62435-8 has been prepared by subcommittee IEC technical committee 47: Semiconductor devices.

The text of this International Standard is based on the following documents:

| | |
|-------------|------------------|
| CDV | Report on voting |
| 47/2595/CDV | 47/2618/RVC |

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all the parts in the IEC 62435 series, published under the general title *Electronic components – Long-term storage of electronic semiconductor devices*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

This document applies to the long-term storage of passive electronic components.

This is a standard for long-term storage (LTS) of electronic devices drawing on the best long-term storage practices currently known. For the purposes of this document, LTS is defined as any device storage whose duration can be more than 12 months for product scheduled for long duration storage. While intended to address the storage of unpackaged semiconductors and packaged electronic devices, nothing in this document precludes the storage of other items under the storage levels defined herein.

Although it has always existed to some extent, obsolescence of electronic components and particularly of integrated circuits, has become increasingly intense over the last few years.

Indeed, with the existing technological boom, the commercial life of a component has become very short compared with the life of industrial equipment such as that encountered in the aeronautical field, the railway industry or the energy sector.

The many solutions enabling obsolescence to be resolved are now identified. However, selecting one of these solutions should be preceded by a case-by-case technical and economic feasibility study, depending on whether storage is envisaged for field service or production, for example:

- remedial storage as soon as components are no longer marketed;
- preventive storage anticipating declaration of obsolescence.

Taking into account the expected life of some installations, sometimes covering several decades, the qualification times, and the unavailability costs, which can also be very high, the solution to be adopted to resolve obsolescence should often be rapidly implemented. This is why the solution retained in most cases consists in systematically storing components which are in the process of becoming obsolescent.

The technical risks of this solution are, a priori, fairly low. However, it requires perfect mastery of the implemented process and especially of the storage environment, although this mastery becomes critical when it comes to long-term storage.

All handling, protection, storage and test operations are recommended to be performed according to the state of the art.

The application of the approach proposed in this document in no way guarantees that the stored components are in perfect operating condition at the end of this storage. It only comprises a means of minimizing potential and probable degradation factors.

Some electronic device users have the need to store electronic devices for long periods of time. Lifetime buys are commonly made to support production runs of assemblies that will exceed the production timeframe of its individual parts. This puts the user in a situation requiring careful and adequate storage of such parts to maintain the as-received solderability and minimize any degradation effects to the part over time. Major degradation concerns are moisture, electrostatic fields, ultraviolet light, large variations in temperature, air-borne contaminants, and outgassing.

Warranties and sparring also present a challenge for the user or repair agency as some systems have been designated to be used for long periods of time, in some cases for up to 40 years or more. Some of the devices needed for repair of these systems will not be available from the original supplier for the lifetime of the system or the spare assembly may be built with the original production run but then require long-term storage. This document was developed to provide a standard for storing electronic devices for long periods of time. For storage

of devices that are moisture sensitive but that do not need to be stored for long periods of time, IEC TR 62258-3 can be consulted.

Long-term storage assumes that the device is going to be placed in uninterrupted storage for a number of years. It is essential that it is useable after storage. Particular attention should be paid to storage media surrounding the devices together with the local environment.

These guidelines do not imply any warranty of product or guarantee of operation beyond the storage time given by the manufacturer.

The IEC 62435 series is intended to ensure that adequate reliability is achieved for devices in user applications after long-term storage. Users are encouraged to request data from suppliers to applicable specifications to demonstrate a successful storage life as requested by the user. These standards are not intended to address built-in failure mechanisms that would take place regardless of storage conditions.

These standards are intended to give practical guide to methods of long-duration storage of electronic components where this is intentional or planned storage of product for a number of years. Storage regimes for work-in-progress production are managed according to company internal process requirements and are not detailed in this series of standards.

The overall standard is split into a number of parts. Parts 1 to 4 apply to any long-term storage and contain general requirements and guidance, whereas Parts 5 to 9 are specific to the type of product being stored. It is intended that the product specific part should be read alongside the general requirements of Parts 1 to 4.

Electronic components requiring different storage conditions are planned to be covered separately starting with Part 5.

The structure of the IEC 62435 series as currently conceived is as follows:

- Part 1 – General
- Part 2 – Deterioration mechanisms
- Part 3 – Data
- Part 4 – Storage
- Part 5 – Die and wafer devices
- Part 6 – Packaged or finished devices
- Part 7 – MEMS
- Part 8 – Passive electronic devices
- Part 9 – Special cases

ELECTRONIC COMPONENTS – LONG-TERM STORAGE OF ELECTRONIC SEMICONDUCTOR DEVICES –

Part 8: Passive electronic devices

1 Scope

This part of the IEC 62435 series on long-term storage is applied to passive electronic devices in long-term storage that can be used as part of obsolescence mitigation strategy. Long-term storage refers to a duration that can be more than 12 months for product scheduled for storage. Storage typically begins when components are packed at the originating supplier where the pack date or date code are assigned to the product. It is the responsibility of the distributor and the customer to control and manage the aging inventory upon receipt of the dated product. Alternatively, a supplier-customer agreement can be established to manage the aging inventory. Philosophy, good working practice, and general means to facilitate the successful long-term storage of electronic components are also addressed.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60749-20, *Semiconductor devices – Mechanical and climatic test methods – Part 20: Resistance of plastic encapsulated SMDs to the combined effect of moisture and soldering heat*

IEC 60749-20-1, *Semiconductor devices – Mechanical and climatic test methods – Part 20-1: Handling, packing, labelling and shipping of surface-mount devices sensitive to the combined effect of moisture and soldering heat*

IEC 61760-4, *Surface mounting technology – Part 4: Classification, packaging, labelling and handling of moisture sensitive devices*

JEDEC J-STD-075, *Classification of non-IC electronic components for assembly processes*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

3.1

passive, adj

<electronic component> qualifies a circuit element or a circuit for which the time integral of the instantaneous power cannot be negative over any time interval beginning at an instant before the first supply of electric energy

EXAMPLE Resistor, inductor, capacitor, fuse, magnetic switch, crystal oscillator, diode, led

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